

## SIC MOSFET

#### CoolSiC™ MOSFET 650 V G2

Built on Infineon's robust 2<sup>nd</sup> generation Silicon Carbide trench technology, the 650 V CoolSiC™ MOSFET delivers unparalleled performance, superior reliability, and great ease of use. It enables cost effective, highly efficient, and simplified designs to fulfill the ever-growing system and market needs.

#### **Features**

- Ultra-low switching losses
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.5 \text{ V}$
- Robust against parasitic turn-on even with 0 V turn-off gate voltage
- Flexible driving voltage and compatible with bipolar driving scheme
- Robust body diode operation under hard commutation events
- .XT interconnection technology for best-in-class thermal performance

#### **Benefits**

- · Enables high efficiency and high power density designs
- Facilitates great ease of use and integration
- Provides the best price performance ratio compared to Industry's most ambitious roadmaps
- · Reduces the size, weight and bill of materials of the systems
- Enhances system robustness and reliability

### Potential applications

- SMPS
- Solar PV inverters
- · Energy storage and battery formation
- UPS
- EV charging infrastructure
- Motor drives

#### **Product validation**

Fully qualified according to JEDEC for Industrial Applications

Please note: The source and driver source pins are not exchangeable. Their exchange might lead to malfunction.

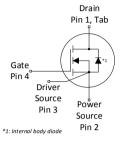
Table 1 Key Performance Parameters

Parameter	Value	Unit
$V_{\rm DSS}$ over full $T_{\rm j,range}$	650	V
$R_{\mathrm{DS(on),typ}}$	26	mΩ
R <sub>DS(on),max</sub>	33	mΩ
$Q_{G,typ}$	42	nC
I <sub>D,pulse</sub>	215	А
Q <sub>oss</sub> @ 400 V	80	nC
E <sub>oss</sub> @ 400 V	10.8	μJ

Type/Ordering Code	Package	Marking	Related Links
IMZA65R026M2H	PG-TO247-4	65R026M2	see Appendix A









#### Public

### CoolSiC™ MOSFET 650 V G2 IMZA65R026M2H



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# 1 Maximum ratings

at  $T_i = 25$ °C, unless otherwise specified.

Note: for optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Table 2 Maximum ratings

Parameter	Symbol	,	Value	s	Unit	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Мах.	Onic	Note/ Test Condition
Continuous DC drain current 1)	I <sub>DDC</sub>	-	-	64 45.3	А	$T_c = 25$ °C $T_c = 100$ °C
Peak drain current <sup>2)</sup>	I <sub>DM</sub>	-	-	215	А	$T_{\rm c} = 25^{\circ} \text{C}, \ V_{\rm GS} = 18 \text{ V}$
Avalanche energy, single pulse	E <sub>AS</sub>	-	-	200	mJ	I <sub>D</sub> = 7.5 A, V <sub>DD</sub> = 50 V; see table 11
Avalanche energy, repetitive	E <sub>AR</sub>	-	-	1.00	mJ	I <sub>D</sub> = 7.5 A, V <sub>DD</sub> = 50 V; see table 11
Avalanche current, single pulse	I <sub>AS</sub>	-	-	7.5	А	-
MOSFET dv/dt ruggedness	dv/dt	-	-	200	V/ns	V <sub>DS</sub> = 0400 V
Gate source voltage (static) 3)	$V_{GS}$	-7	-	23	V	-
Gate source voltage (transient)	$V_{\rm GS}$	-10	-	25	V	t <sub>p</sub> ≤ 500 ns, duty cycle ≤ 1%
Power dissipation	P <sub>tot</sub>	-	-	227	W	$T_{\rm c} = 25^{\circ}\text{C}$
Storage temperature	$T_{\rm stg}$	-55	-	150	°C	-
Operating junction temperature	$T_{\rm j}$	-55	-	175	°C	-
Mounting torque	-	-	-	60	Ncm	M3 and M3.5 screws
Continuous reverse drain current 1)	I <sub>SDC</sub>	-	-	64 42.0	А	$V_{GS} = 18 \text{ V}, T_c = 25^{\circ}\text{C}$ $V_{GS} = 0 \text{ V}, T_c = 25^{\circ}\text{C}$
Peak reverse drain current <sup>2)</sup>	I <sub>SM</sub>	-	-	215 65	А	$T_c = 25$ °C, $t_p \le 250$ ns $T_c = 25$ °C
Insulation withstand voltage	V <sub>ISO</sub>	-	-	n.a.	V	$V_{\rm rms}$ , $T_{\rm c} = 25^{\circ}$ C, $t = 1$ min

<sup>1)</sup> Limited by  $T_{j,max}$ .

Pulse width  $t_{\text{pulse}}$  limited by  $T_{\text{j,max}}$ .

The maximum gate-source voltage in the application design should be in accordance to IPC-9592B.



## 2 Thermal characteristics

#### Table 3 Thermal characteristics

Dament at an	Symala al	Values			11	Note / Took Con diking
Parameter	Symbol	Min.	Тур.	Мах.	Unit	Note/ Test Condition
Thermal resistance, junction - case	$R_{th(j-c)}$	-	-	0.66	°C/W	Not subject to production test. Parameter verified by design/characterization according to JESD51-14.
Soldering temperature, wavesoldering only allowed at leads	$T_{\text{sold}}$	_	-	260	°C	1.6 mm (0.063 in.) from case for 10 s



# 3 Operating range

### Table 4 Operating range

Parameter	Symbol	,	Values	5	Unit	Note/ Test Condition
raiailietei	Syllibot	Min.	Тур.	Мах.		
Recommended turn-on voltage	$V_{GS(on)}$	-	18	1	٧	-
Recommended turn-off voltage	$V_{GS(off)}$	-	0	-	V	-



#### 4 Electrical characteristics

at  $T_i = 25$ °C, unless otherwise specified

Table 5 Static characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition
raianietei	Syllibot	Min.	Тур.	Мах.	Oilit	Note/ Test Condition
Drain-source voltage	$V_{ m DSS}$	650	-	-	V	$V_{\rm GS} = 0 \text{ V}, I_{\rm D} = 0.7 \text{ mA}$
Gate threshold voltage <sup>4)</sup>	$V_{\rm GS(th)}$	3.5	4.5	5.6	V	$V_{\rm DS} = V_{\rm GS}$ , $I_{\rm D} = 7$ mA
Zero gate voltage drain current	I <sub>DSS</sub>	_	1 3	75 -	μΑ	$V_{\rm DS} = 650 \text{ V}, V_{\rm GS} = 0 \text{ V}, T_{\rm j} = 25^{\circ}\text{C}$ $V_{\rm DS} = 650 \text{ V}, V_{\rm GS} = 0 \text{ V}, T_{\rm j} = 175^{\circ}\text{C}$
Gate-source leakage current	$I_{\rm GSS}$	-	-	100	nA	$V_{\rm GS} = 20 \text{ V}, \ V_{\rm DS} = 0 \text{ V}$
Drain-source on-state resistance	$R_{ m DS(on)}$	-	34 26 24 43	- 33 - -	mΩ	$V_{GS} = 15 \text{ V}, I_D = 34.5 \text{ A}, T_j = 25^{\circ}\text{C}$ $V_{GS} = 18 \text{ V}, I_D = 34.5 \text{ A}, T_j = 25^{\circ}\text{C}$ $V_{GS} = 20 \text{ V}, I_D = 34.5 \text{ A}, T_j = 25^{\circ}\text{C}$ $V_{GS} = 18 \text{ V}, I_D = 34.5 \text{ A}, T_j = 175^{\circ}\text{C}$
Internal gate resistance	$R_{G,int}$	-	2.9	-	Ω	f= 1 MHz

Tested after 1 ms pulse at  $V_{GS}$  = +20 V. "Linear mode" operation is not recommended. For assessment of potential "linear mode" operation, please contact Infineon sales office.

#### Table 6 Dynamic characteristics

External parasitic elements (PCB layout) influence switching behavior significantly. Stray inductances and coupling capacitances must be minimized. For layout recommendations please use provided application notes or contact Infineon sales office.

Parameter	Symbol	Values			Unit	Note/ Test Condition
raiametei	Syllibot	Min.	Тур.	Мах.	Offic	Note/ Test Condition
Input capacitance	C <sub>iss</sub>	-	1499	-	pF	$V_{\rm GS} = 0 \text{ V}, V_{\rm DS} = 400 \text{ V}, f = 250 \text{ kHz}$
Reverse transfer capacitance	$C_{\rm rss}$	-	8.6	-	pF	$V_{\rm GS} = 0 \text{ V}, V_{\rm DS} = 400 \text{ V}, f = 250 \text{ kHz}$
Output capacitance <sup>5)</sup>	C <sub>oss</sub>	-	111	144	pF	$V_{GS} = 0 \text{ V}, V_{DS} = 400 \text{ V}, f = 250 \text{ kHz}$
Output charge <sup>5)</sup>	$Q_{\rm oss}$	-	80	104	nC	calculation based on C <sub>oss</sub>
Effective output capacitance, energy related <sup>6)</sup>	$C_{ m o(er)}$	-	135	-	pF	$V_{GS} = 0 \text{ V},$ $V_{DS} = 0400 \text{ V}$
Effective output capacitance, time related <sup>7)</sup>	$C_{ m o(tr)}$	-	199	-	pF	$I_{\rm D}$ = constant, $V_{\rm GS}$ = 0 V, $V_{\rm DS}$ = 0400 V
Turn-on delay time	$t_{ m d(on)}$	-	9.3	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 34.5  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10
Rise time	t <sub>r</sub>	-	10.1	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 34.5  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10



#### Table 6 Dynamic characteristics

External parasitic elements (PCB layout) influence switching behavior significantly. Stray inductances and coupling capacitances must be minimized. For layout recommendations please use provided application notes or contact Infineon sales office.

Parameter	Symbol	Values			Unit	Note / Test Condition
- raiailletei	Syllibot	Min.	Тур.	Мах.	Offic	Note/ Test Condition
Turn-off delay time	$t_{ m d(off)}$	-	16	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 34.5  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10
Fall time	$t_{\rm f}$	-	5.1	-	ns	$V_{\rm DD} = 400  \text{V}, \ V_{\rm GS} = 0/18  \text{V},$ $I_{\rm D} = 34.5  \text{A}, \ R_{\rm G,ext} = 1.8  \Omega;$ see table 10
Turn-ON switching losses <sup>8)</sup>	E <sub>on</sub>	-	43	-	μJ	$V_{\rm DD} = 400 \text{ V}, V_{\rm GS} = 0/18 \text{ V},$ $I_{\rm D} = 34.5 \text{ A}, R_{\rm G,ext} = 1.8 \Omega$
Turn-OFF switching losses <sup>8)</sup>	$E_{ m off}$	-	33	-	μJ	$V_{\rm DD} = 400 \text{ V}, V_{\rm GS} = 0/18 \text{ V},$ $I_{\rm D} = 34.5 \text{ A}, R_{\rm G,ext} = 1.8 \Omega$
Total switching losses <sup>8)</sup>	E <sub>tot</sub>	_	76	-	μJ	$V_{\rm DD} = 400 \text{ V}, V_{\rm GS} = 0/18 \text{ V},$ $I_{\rm D} = 34.5 \text{ A}, R_{\rm G,ext} = 1.8 \Omega$

<sup>5)</sup> Maximum specification is defined by calculated six sigma upper confidence bound.

Table 7 Gate charge characteristics

Dorometer	Symbol	Values			l lmit	Note / Test Condition
Parameter	Syllibot	Min.	Тур.	Мах.	Unit	Note/ Test Condition
Plateau gate to source charge	$Q_{GS(pl)}$	-	11.0	-	nC	$V_{\rm DD} = 400 \text{ V}, I_{\rm D} = 34.5 \text{ A},$ $V_{\rm GS} = 0 \text{ to } 18 \text{ V}$
Gate to drain charge	$Q_{GD}$	-	7.6	-	nC	$V_{\rm DD} = 400 \text{ V}, I_{\rm D} = 34.5 \text{ A},$ $V_{\rm GS} = 0 \text{ to } 18 \text{ V}$
Total gate charge	$Q_{G}$	-	42	-	nC	$V_{\rm DD} = 400 \text{ V}, I_{\rm D} = 34.5 \text{ A},$ $V_{\rm GS} = 0 \text{ to } 18 \text{ V}$

Table 8 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note/ Test Condition
raiametei	Symbol	Min.	Тур.	Мах.	Ollic	Note/ Test Condition
Drain-source reverse voltage	$V_{\rm SD}$	-	4.3	-	V	$V_{\rm GS} = 0 \text{ V}, I_{\rm S} = 34.5 \text{ A}, T_{\rm j} = 25^{\circ}\text{C}$
MOSFET forward recovery time	t <sub>fr</sub>	-	16 10.7	-	ns	$V_{DD} = 400 \text{ V}, I_{S} = 34.5 \text{ A},$ $di_{S}/dt = 1000 \text{ A/}\mu\text{s}; \text{ see table 9}$ $V_{DD} = 400 \text{ V}, I_{S} = 34.5 \text{ A},$ $di_{S}/dt = 4000 \text{ A/}\mu\text{s}; \text{ see table 9}$

 $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

<sup>7)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400 V.

<sup>&</sup>lt;sup>8)</sup> Values for 4-pin configuration based on TO-263-7 measurements; MOSFET used in half-bridge configuration without external diode.



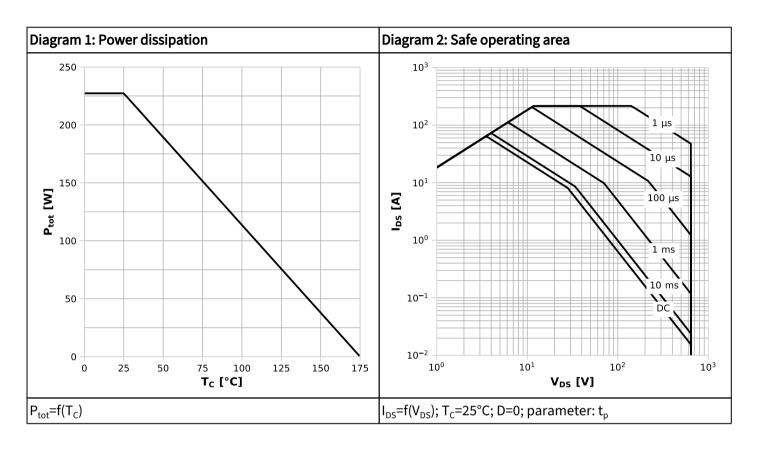
#### Table 8 Reverse diode characteristics

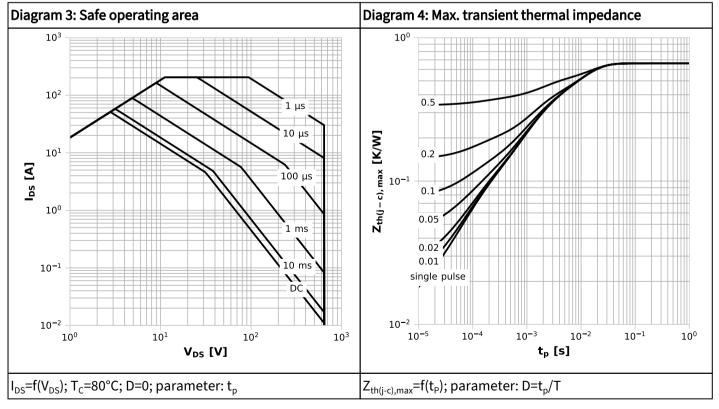
Parameter	Symbol -	Values			Unit	Note/ Test Condition
- arameter		Min.	Тур.	Мах.	Oilit	Note/ Test Condition
MOSFET forward recovery charge <sup>9)</sup>	$Q_{fr}$	-	83 131	-	nC	$V_{\rm DD} = 400 \text{V},  I_{\rm S} = 34.5 \text{A},$ $di_{\rm S}/dt = 1000 \text{A/\mu s};  \text{see table 9}$ $V_{\rm DD} = 400 \text{V},  I_{\rm S} = 34.5 \text{A},$ $di_{\rm S}/dt = 4000 \text{A/\mu s};  \text{see table 9}$
MOSFET peak forward recovery current	$I_{frm}$	-	10.6 25	-	А	$V_{\rm DD} = 400 \text{V},  I_{\rm S} = 34.5 \text{A},$ $di_{\rm S}/dt = 1000 \text{A/\mu s};  \text{see table 9}$ $V_{\rm DD} = 400 \text{V},  I_{\rm S} = 34.5 \text{A},$ $di_{\rm S}/dt = 4000 \text{A/\mu s};  \text{see table 9}$

<sup>9)</sup>  $Q_{fr}$  includes  $Q_{oss}$ .

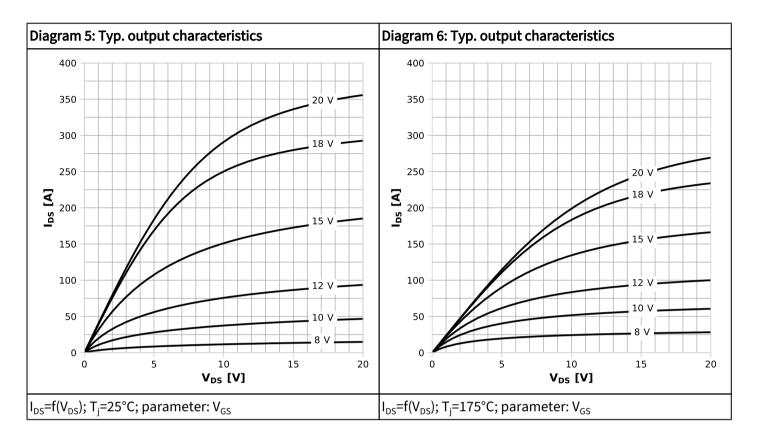


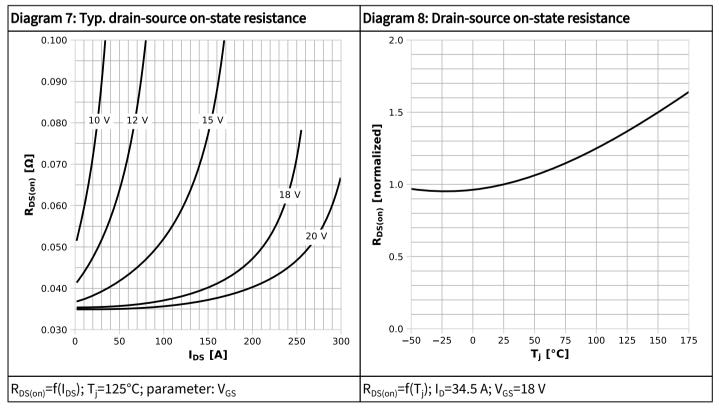
# 5 Electrical characteristics diagrams



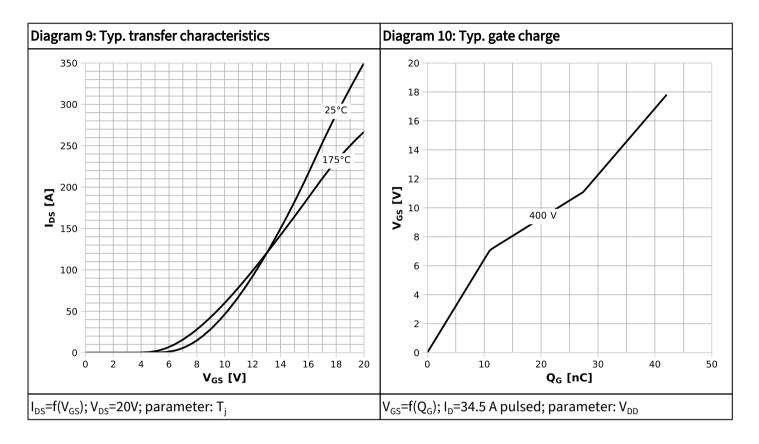


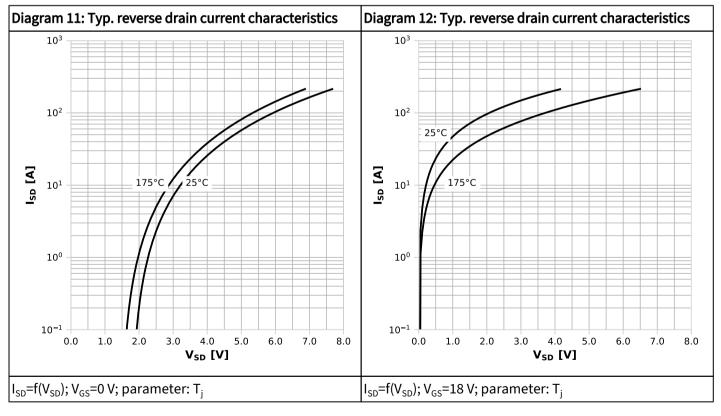




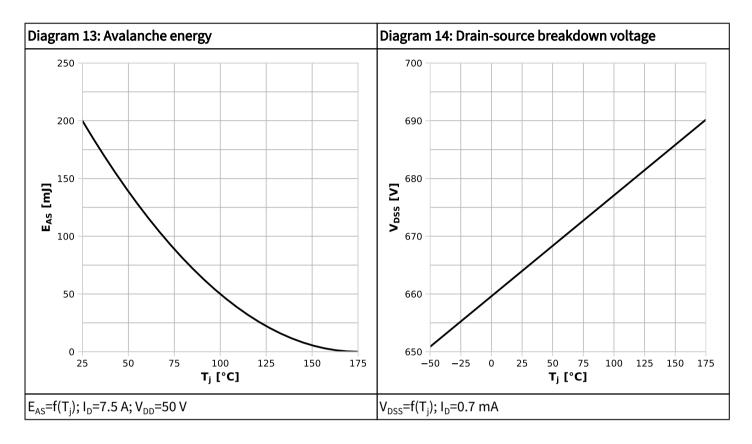


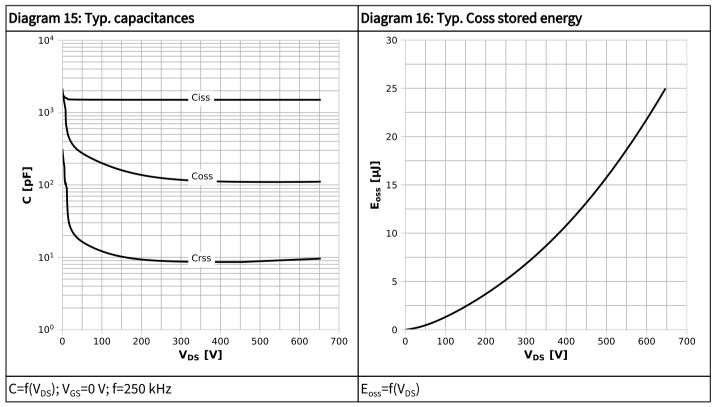




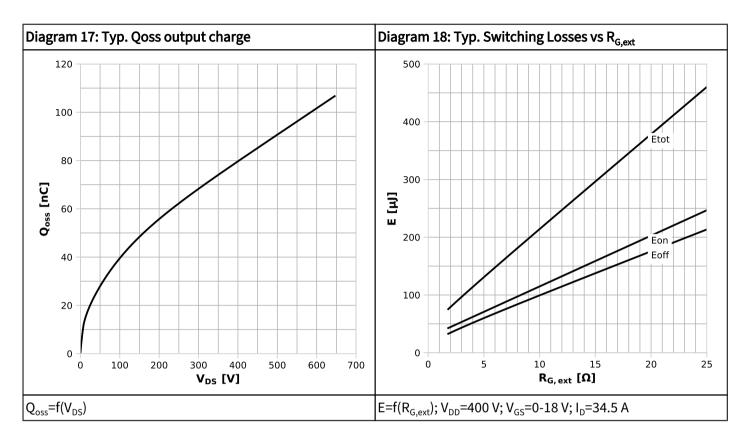


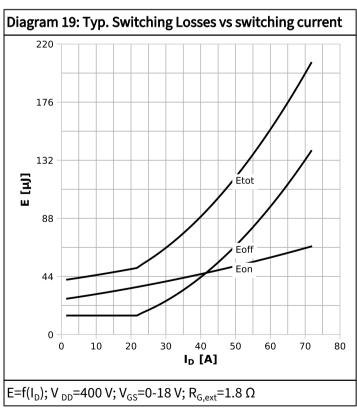














### 6 Test Circuits

Table 9 Body diode characteristics (CoolSiC)

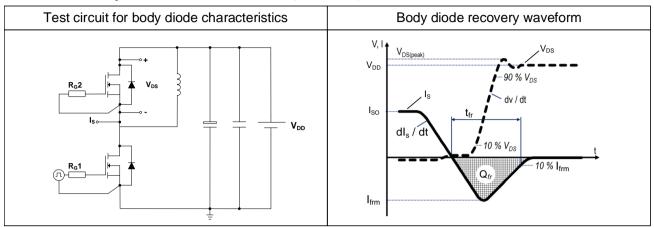


Table 10 Switching times (CoolSiC)

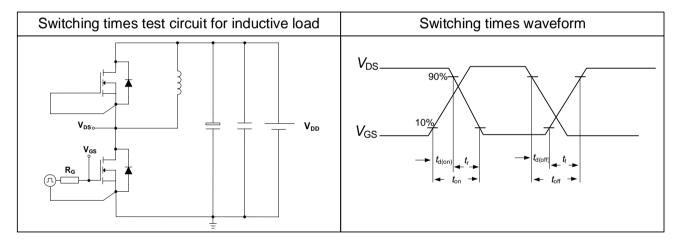
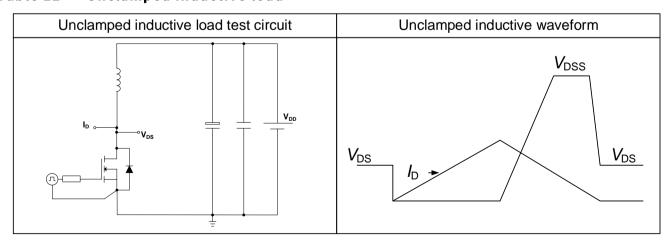
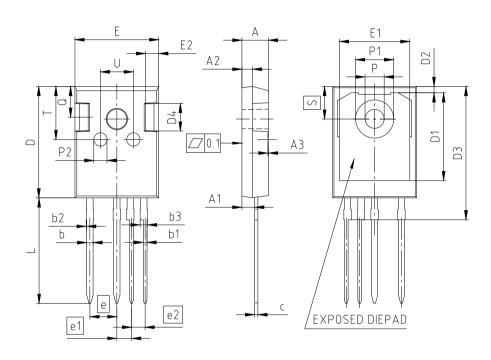


Table 11 Unclamped inductive load





# 7 Package Outlines



NOTES:
DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSION OR GATE BURRS

PACKAGE - GROUP NUMBER:	PG-TO2	47-4-U02			
DIMENSIONS	MILLIMETERS			MILLIMETERS	
DIMENSIONS	MIN.	MAX.	DIMENSIONS	MIN.	MAX.
Α	4.90	5.10	E	15.70	15.90
A1	2.31	2.51	E1	13.10	13.50
A2	1.90	2.10	E2	2.40	2.60
A3	0.05	0.25	е	5.08	
b	1.10	1.30	e1	2.79	
b1	0.65	0.79	e2	2.54	
b2		0.20	N	4	
b3	1.34	1.44	L	19.80	20.10
С	0.58	0.66	øΡ	3.50	3.70
D	20.90	21.10	øP1	7.00	7.40
D1	16.25	16.85	øP2	2.40	2.60
D2	1.05	1.35	Q	5.60	6.00
D3	24.97	25.27	S	6.15	
D4	4.90	5.10	Т	9.80	10.20
			U	6.00	6.40

Figure 1 Outline PG-TO247-4, dimensions in mm



# 8 Appendix A

#### Table 12 Related Links

- IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Webpage
- IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Application Note
- IFX CoolSiC CoolSiC™ MOSFET 650 V G2 Simulation Model
- IFX Design tools



#### **Revision History**

IMZA65R026M2H

#### Revision 2024-09-24, Rev. 2.0

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Pre	VIOI.	ıςR	AV/IS	sion

Revision Date Subjects (major changes since last revision)		Subjects (major changes since last revision)
2.0	2024-09-24	Release of final

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#### Information

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#### Warnings

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